

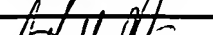


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[illegible]

Nguyen, Leon-Viet Q (Assistant Examiner)	11/19/07 (Date)	 DAVID C. PAYNE SUPERVISORY PATENT EXAMINER	Total Claims Allowed: 7		
 (Legal Instruments Examiner)	12/2/07 (Date)	(Primary Examiner)	12/5/07 (Date)	O.G. Print Claim(s) 3	O.G. Print Figure 2